

Search Notes

Application/Control No.

10/674,260

Examiner

Kelly L. Jerabek

Applicant(s)/Patent under
Reexamination

OKISU ET AL.

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner
348	333.01	12/19/2006	KJ
	333.02		
	333.05		
	231.2		
	231.3		
	231.5		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
IEEE	12/19/2006	KJ
EAST Keyword	12/19/2006	